Search N	lotes

Application/Control N .	Applicant(s)/Patent under Reexamination		
10/061,155	SHIRAIWA, YOSHINOBU		
Examiner	Art Unit		
Peter K Huntsinner	2624		

SEARCHED				
Class	Subclass	Date	Examiner	
358	1.1, 1.15	7/20/2005	РКН	
348	207.2	7/20/2005	РКН	
RSCH	Above	1/9/06	PKH	
RSCH RSCH	Abas	6/21/06	PKH	
RECH	Abar	12/10/25	PKH	
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INTERFERENCE SEARCHED			
Class	·Subclass	Date ·	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	ĖXMR	
East Search	7/20/2005	РКН	
Consultation with David Moore	7/20/2005	РКН	
Consultation with 2600 Panel on U.S.C. 101	7/20/2005	РКН	